

# IRFS4115PbF IRFSL4115PbF

HEXFET® Power MOSFET

## **Applications**

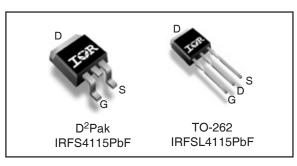
- High Efficiency Synchronous Rectification in SMPS
- Uninterruptible Power Supply
- High Speed Power Switching
- Hard Switched and High Frequency Circuits

# G

V <sub>DSS</sub>		150V
R <sub>DS(on)</sub> ty	/p.	10.3m $\Omega$
	nax.	<b>12.1m</b> $Ω$
I <sub>D (Silicon Li</sub>	mited)	99A ①
I <sub>D (Package</sub>	Limited)	195A

### **Benefits**

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- Lead-Free



G	D	S
Gate	Drain	Source

**Absolute Maximum Ratings** 

Symbol	Parameter	Max.	Units
$I_D @ T_C = 25^{\circ}C$	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	99①	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	70 ①	,
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Wire Bond Limited)	195	A
I <sub>DM</sub>	Pulsed Drain Current ②	396	
$P_{D} @ T_{C} = 25^{\circ}C$	Maximum Power Dissipation	375	W
	Linear Derating Factor	2.5	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
dv/dt	Peak Diode Recovery ®	18	V/ns
T <sub>J</sub>	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300	
	(1.6mm from case)		
	Mounting torque, 6-32 or M3 screw	10lb·in (1.1N·m)	

### **Avalanche Characteristics**

E <sub>AS (Thermally limited)</sub>	Single Pulse Avalanche Energy 3	830	mJ
I <sub>AR</sub>	Avalanche Current ②	See Fig. 14, 15, 22a, 22b,	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ⑤		mJ

### Thermal Resistance

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Symbol	Parameter	Тур.	Max.	Units	
$R_{\theta JC}$	Junction-to-Case 9®		0.4	°C/W	
$R_{\theta JA}$	Junction-to-Ambient ® ®		40	C/VV	

# Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	150			٧	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.18		V/°C	Reference to 25°C, $I_D = 3.5$ mA <sup>②</sup>
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		10.3	12.1	mΩ	$V_{GS} = 10V, I_D = 62A$ (5)
$V_{GS(th)}$	Gate Threshold Voltage	3.0		5.0	٧	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20	μΑ	$V_{DS} = 150V, V_{GS} = 0V$
				250		$V_{DS} = 150V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100		$V_{GS} = -20V$
$R_G$	Internal Gate Resistance		2.3		Ω	

# Dynamic @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	97			S	$V_{DS} = 50V, I_{D} = 62A$
$Q_g$	Total Gate Charge		77	120	nC	$I_D = 62A$
$Q_{gs}$	Gate-to-Source Charge		28			$V_{DS} = 75V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		26			V <sub>GS</sub> = 10V ⑤
Q <sub>sync</sub>	Total Gate Charge Sync. (Q <sub>g</sub> - Q <sub>gd</sub> )		51			$I_D = 62A, V_{DS} = 0V, V_{GS} = 10V$
t <sub>d(on)</sub>	Turn-On Delay Time		18		ns	$V_{DD} = 98V$
t <sub>r</sub>	Rise Time		73			$I_D = 62A$
t <sub>d(off)</sub>	Turn-Off Delay Time		41			$R_G = 2.2\Omega$
t <sub>f</sub>	Fall Time		39			V <sub>GS</sub> = 10V ⑤
C <sub>iss</sub>	Input Capacitance		5270		pF	$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		490			$V_{DS} = 50V$
C <sub>rss</sub>	Reverse Transfer Capacitance		105			f = 1.0  MHz,  See Fig. 5
C <sub>oss</sub> eff. (ER)	Effective Output Capacitance (Energy Related)		460			$V_{GS} = 0V$ , $V_{DS} = 0V$ to 120V $\bigcirc$ , See Fig. 11
C <sub>oss</sub> eff. (TR)	Effective Output Capacitance (Time Related)		530			$V_{GS} = 0V$ , $V_{DS} = 0V$ to 120V ®

### **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current	_		99	Α	MOSFET symbol
	(Body Diode)					showing the
I <sub>SM</sub>	Pulsed Source Current			396	Α	integral reverse
	(Body Diode) ②					p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C$ , $I_S = 62A$ , $V_{GS} = 0V$ $\$$
t <sub>rr</sub>	Reverse Recovery Time		86		ns	$T_J = 25^{\circ}C$ $V_R = 130V$ ,
			110			$T_{J} = 125^{\circ}C$ $I_{F} = 62A$
Q <sub>rr</sub>	Reverse Recovery Charge		300		nC	$T_J = 25^{\circ}C$ di/dt = 100A/ $\mu$ s $\odot$
			450			$T_J = 125^{\circ}C$
I <sub>RRM</sub>	Reverse Recovery Current		6.5		Α	$T_J = 25^{\circ}C$
t <sub>on</sub>	Forward Turn-On Time	Intrinsi	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)			

### Notes:

- ① Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 195A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements. (Refer to AN-1140)
- ② Repetitive rating; pulse width limited by max. junction temperature.

- ⑤ Pulse width  $\leq 400 \mu s$ ; duty cycle  $\leq 2\%$ .
- ① Calculated continuous current based on maximum allowable junction ⑤ Coss eff. (TR) is a fixed capacitance that gives the same charging time temperature. Bond wire current limit is 195A. Note that current as Coss while VDs is rising from 0 to 80% VDss.
  - $\ \ \,$  C  $_{oss}$  eff. (ER) is a fixed capacitance that gives the same energy as C  $_{oss}$  while V  $_{DS}$  is rising from 0 to 80% V  $_{DSS}.$
  - When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
  - $\ \ \,$   $\ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \,$   $\ \ \,$   $\ \ \,$   $\ \,$   $\ \ \,$   $\ \,$   $\ \ \,$   $\ \,$   $\ \ \,$   $\ \,$   $\ \,$   $\ \,$   $\ \,$   $\ \,$   $\ \,$   $\ \,$   $\ \,$   $\ \,$   $\ \,$   $\ \,$   $\ \,$   $\ \,$   $\ \,$   $\ \,$   $\ \,$   $\ \,$   $\ \,$
  - R<sub>θ,JC</sub> value shown is at time zero.

2 www.irf.com

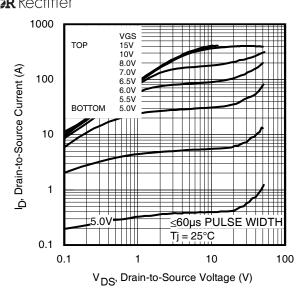


Fig 1. Typical Output Characteristics

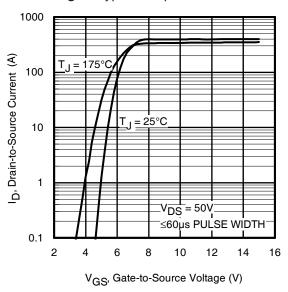
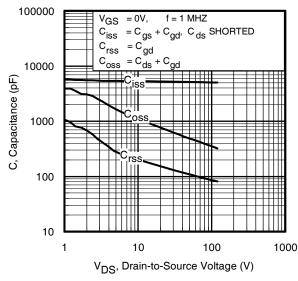


Fig 3. Typical Transfer Characteristics



**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage www.irf.com

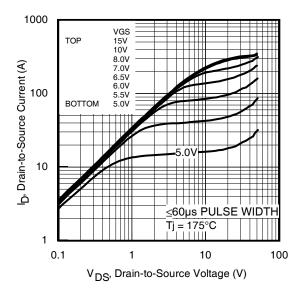


Fig 2. Typical Output Characteristics

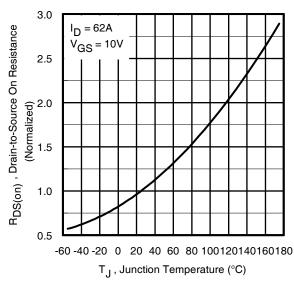


Fig 4. Normalized On-Resistance vs. Temperature

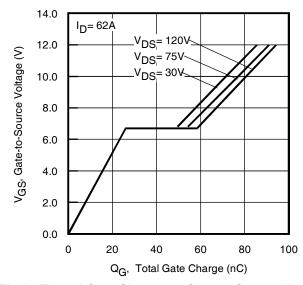


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

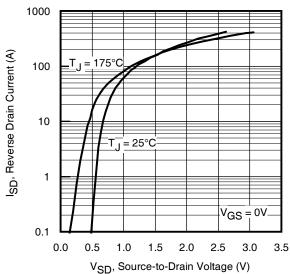
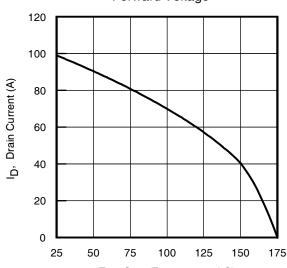


Fig 7. Typical Source-Drain Diode Forward Voltage



T<sub>C</sub>, Case Temperature (°C) **Fig 9.** Maximum Drain Current vs.

Case Temperature

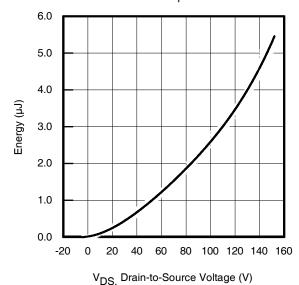


Fig 11. Typical C<sub>OSS</sub> Stored Energy

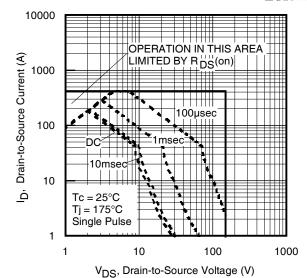


Fig 8. Maximum Safe Operating Area

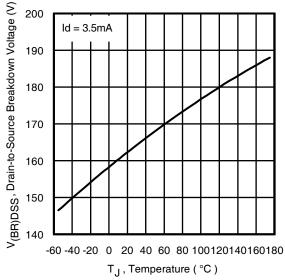


Fig 10. Drain-to-Source Breakdown Voltage

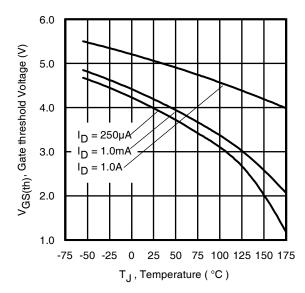


Fig 12. Threshold Voltage vs. Temperature

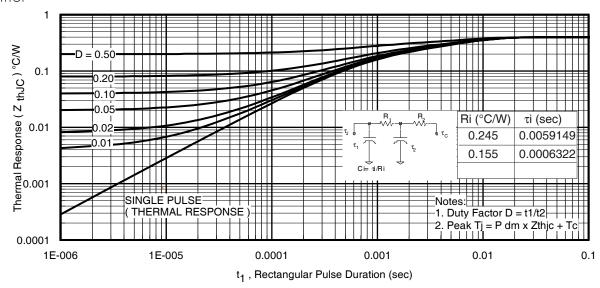


Fig. 13 Maximum Effective Transient Thermal Impedance, Junction-to-Case

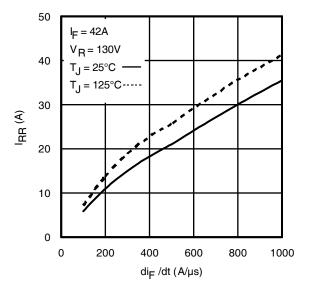


Fig. 14 - Typical Recovery Current vs. dif/dt

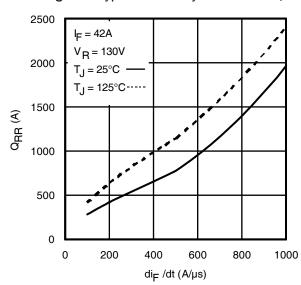


Fig. 16 - Typical Stored Charge vs. di<sub>f</sub>/dt

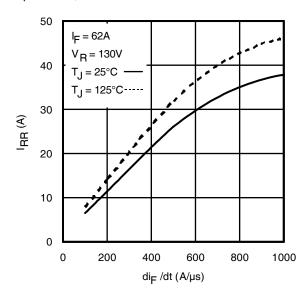


Fig. 15 - Typical Recovery Current vs. dif/dt

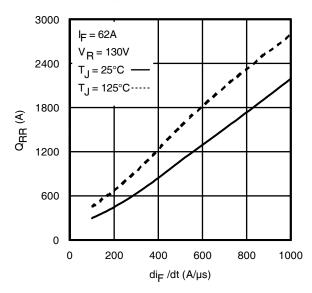


Fig. 17 - Typical Stored Charge vs. dif/dt

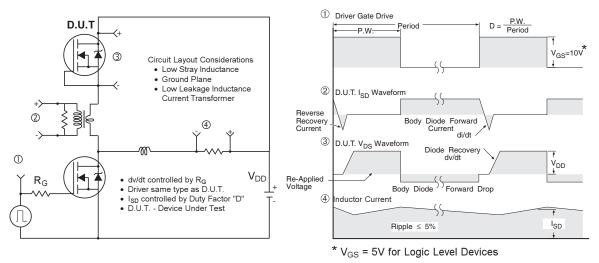


Fig 18. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

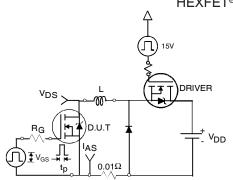


Fig 19a. Unclamped Inductive Test Circuit

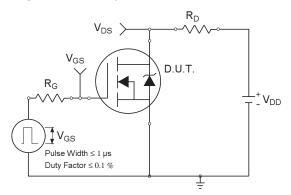


Fig 20a. Switching Time Test Circuit

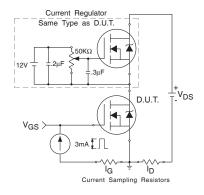


Fig 21a. Gate Charge Test Circuit

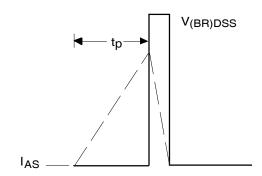


Fig 19b. Unclamped Inductive Waveforms

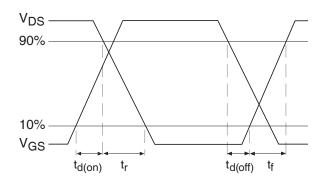


Fig 20b. Switching Time Waveforms

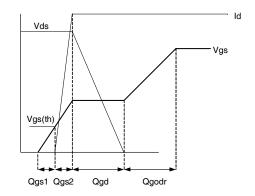
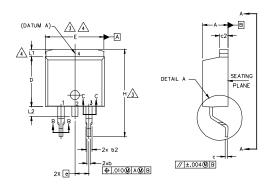


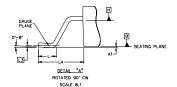
Fig 21b. Gate Charge Waveform

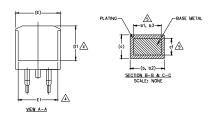
# D<sup>2</sup>Pak (TO-263AB) Package Outline

Dimensions are shown in millimeters (inches)









### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S Y		N			
M B O	MILLIM	ETERS			O T E S
0 L	MIN.	MAX.	MIN.	MAX.	E S
Α	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
b	0.51	0.99	.020	.039	
ь1	0.51	0.89	.020	.035	5
b2	1,14	1.78	.045	.070	
b3	1,14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	-	.270		4
Ε	9.65	10.67	.380	.420	3,4
E1	6.22	-	.245		4
e	2.54	BSC	.100	BSC	
Н	14.61	15,88	.575	.625	
L	1,78	2.79	.070	.110	
L1	-	1.65	-	.066	4
L2	1,27	1.78	-	.070	
L3	0.25	BSC	.010 BSC		
L4	4.78	5.28	.188	.208	

### LEAD ASSIGNMENTS

### HEXFET

1.- GATE 2, 4.- DRAIN 3.- SOURCE

### IGBTs, CoPACK

1.- GATE
2, 4.- COLLECTOR
3.- EMITTER

### DIODES

1.- ANODE \*
2, 4.- CATHODE
3.- ANODE

\* PART DEPENDENT,

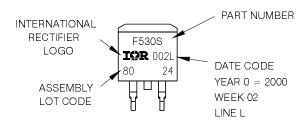
# D<sup>2</sup>Pak (TO-263AB) Part Marking Information

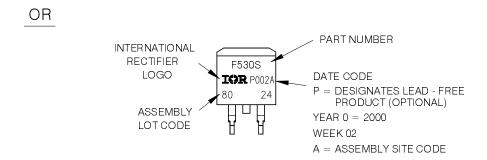
EXAMPLE: THIS IS AN IRF530S WITH

LOT CODE 8024

ASSEMBLED ON WW 02, 2000 IN THE ASSEMBLY LINE "L"

Note: "P" in assembly line position indicates "Lead — Free"



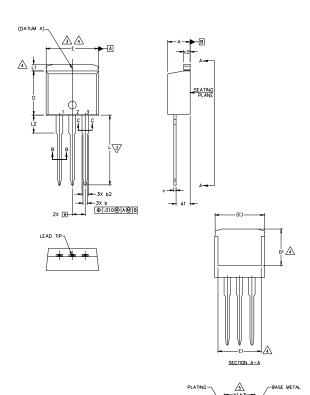


# IRFS/SL4115PbF

# TO-262 Package Outline

Dimensions are shown in millimeters (inches)





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14,5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3 DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

- 6. CONTROLLING DIMENSION: INCH.
- 7.— OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

S Y		N			
M B O L	MILLIM	ETERS	INC	NOTES	
L	MIN.	MAX.	MIN.	MAX,	S
Α	4.06	4,83	.160	.190	
A1	2.03	3.02	.080	.119	
ь	0.51	0.99	.020	.039	
ь1	0.51	0.89	.020	.035	5
b2	1,14	1,78	.045	.070	
b3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	-	.270	-	4
Ε	9.65	10.67	.380	.420	3,4
E1	6.22	-	.245		4
е	2,54	BSC	,100 BSC		
L	13.46	14.10	.530	.555	
L1	-	1.65	-	.065	4
L2	3.56	3,71	.140	,146	

### LEAD ASSIGNMENTS

### HEXFET

- 1.- GATE
- 2.- DRAIN 3.- SOURCE
- 4.- DRAIN

### IGBTs, CoPACK

- 2.- COLLECTOR
  3.- EMITTER
  4.- COLLECTOR

# TO-262 Part Marking Information

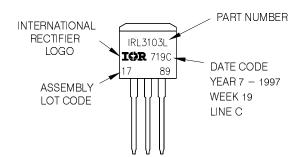
EXAMPLE: THIS IS AN IRL3103L

LOT CODE 1789 ASSEMBLED ON WW 19, 1997

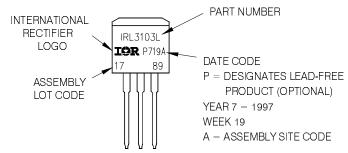
SECTION B-B & C-C SCALE: NONE

IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead - Free"



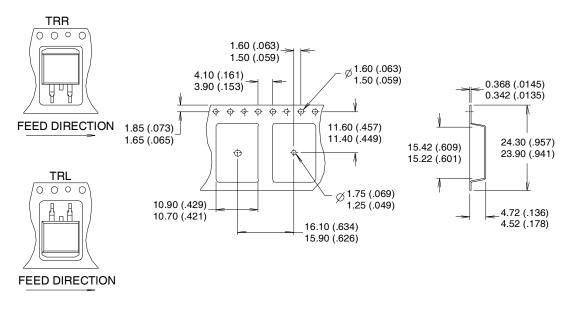
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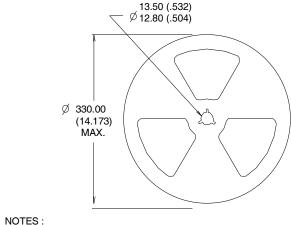


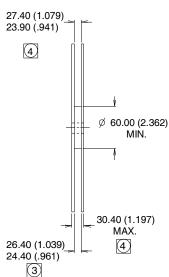
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

# D<sup>2</sup>Pak (TO-263AB) Tape & Reel Information

Dimensions are shown in millimeters (inches)







1. COMFORMS TO EIA-418.

- 2. CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION MEASURED @ HUB.
- INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

Data and specifications subject to change without notice. This product has been designed and qualified for the Industrial market.

Qualification Standards can be found on IR's Web site.



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